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**Prabhat Verma
Alexander Egner**
Editors

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Contents

v	<i>Authors</i>
vii	<i>Conference Committee</i>

PLASMON-ENHANCED RAMAN SPECTROSCOPY/MICROSCOPY I

10350 03	Extension of nano-scaled exploration into solution/liquid systems using tip-enhanced Raman scattering (Invited Paper) [10350-2]
10350 05	Evaluation of probes for tip-enhanced Raman scattering by darkfield microspectroscopy and calculation [10350-4]

SUPERRESOLUTION: NEW DEVELOPMENTS I

10350 09	Side lobe suppression in phase mask-based nonlinear superresolution microscopy [10350-8]
----------	---

PLASMON-ENHANCED RAMAN SPECTROSCOPY/MICROSCOPY II

10350 0A	Tip-enhanced Raman spectroscopy of semiconductor nanostructures (Invited Paper) [10350-9]
----------	--

PLASMON-ENHANCED RAMAN SPECTROSCOPY/MICROSCOPY III

10350 0I	Physical chemistry of Nanogap-Enhanced Raman Scattering (NERS) (Invited Paper) [10350-17]
----------	--

SUPERRESOLUTION: NEW DEVELOPMENTS II

10350 0P	Nanoscale Photoacoustic Tomography (nPAT) for label-free super-resolution 3D imaging of red blood cells [10350-24]
----------	---

NEAR-FIELD SPECTROSCOPY/MICROSCOPY

10350 0S	Near-field visible light absorption imaging by Raman-nano-light source [10350-27]
----------	--

POSTER SESSION

10350 12	Three-dimensional nanoscale optical vortex profilometry [10350-37]
----------	---

Authors

Numbers in the index correspond to the last two digits of the seven-digit citation identifier (CID) article numbering system used in Proceedings of SPIE. The first five digits reflect the volume number. Base 36 numbering is employed for the last two digits and indicates the order of articles within the volume. Numbers start with 00, 01, 02, 03, 04, 05, 06, 07, 08, 09, 0A, 0B...0Z, followed by 10-1Z, 20-2Z, etc.

Banerjee, Sanjay, 0A
Beams, Ryan, 09
Brennan, Christopher J., 0A
Conklin, Shelby, 0P
Cossio, Gabriel, 0A
De Palma, Alex, 0A
Dillen, David, 0A
Ekgasit, Sanong, 03
Ghosh, Rudresh, 0A
Hernandez, Armando, 0P
Itoh, Tamitake, 05
Katayama, Ryota, 05
Kato, Ryo, 0S
Kim, Hyun Woo, 0I
Kitahama, Yasutaka, 03, 05
Ozaki, Yukihiro, 03, 05
Pienpinijtham, Prompong, 03
Poletaev, Dmitrii A., 12
Saito, Yuika, 0S
Samant, Pratik, 0P
Sokolenko, Bogdan V., 12
Stranick, Stephan J., 09
Suh, Yung Doug, 0I
Suzuki, Toshiaki, 05
Tutuc, Emanuel, 0A
Uemura, Shohei, 05
Umakoshi, Takayuki, 0S
Vantasin, Sanpon, 03
Verma, Prabhat, 0S
Xiang, Liangzhong, 0P
Yamamoto, Yuko S., 05
Yu, Edward T., 0A
Zhang, Zhongjian, 0A

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Renato Zenobi, ETH Zürich (Switzerland)
Xiaowei Zhuang, Harvard University (United States)

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- 1 Plasmon-Enhanced Raman Spectroscopy/Microscopy I
Prabhat Verma, Osaka University (Japan)
- 2 Superresolution: New Developments I
Keith A. Lidke, The University of New Mexico (United States)
- 3 Plasmon-Enhanced Raman Spectroscopy/Microscopy II
Nan Jiang, University of Illinois at Chicago (United States)
- 4 Superresolution: Single Molecule Localization Microscopy
Alexander Egner, Laser-Laboratorium Göttingen e.V. (Germany)
- 5 Plasmon-Enhanced Raman Spectroscopy/Microscopy III
Erin Wood, National Institute of Standards and Technology
(United States)
- 6 Superresolution: New Developments II
Balpreet S. Ahluwalia, UiT The Arctic University of Norway (Norway)
- 7 Near-Field Spectroscopy/Microscopy
Remo Proietti Zaccaria, Istituto Italiano di Tecnologia (Italy)
Prabhat Verma, Osaka University (Japan)
- 8 Superresolution: New Developments III
Claudia Geisler, Laser-Laboratorium Göttingen e.V. (Germany)
- 9 Plasmonics for Spectroscopy/Microscopy
Andrea Toma, Istituto Italiano di Tecnologia (Italy)